TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type ( $\pi$ -MOS VI)

# **TK16H60C**

#### **Switching Regulator Applications**

Unit: mm

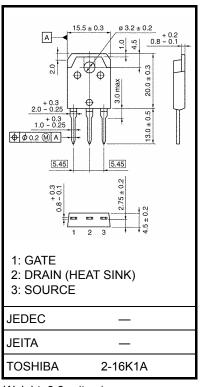
• Low drain-source ON resistance :  $RDS (ON) = 0.32\Omega (typ.)$ • High forward transfer admittance :  $|Y_{fs}| = 11S (typ.)$ 

• Low leakage current :  $I_{DSS} = 100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = 600 \,\text{V})$ 

• Enhancement mode :  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

### Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	600	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	600	V	
Gate-source voltage		V <sub>GSS</sub>	±30	V	
Drain current	DC (Note 1)	I <sub>D</sub>	16	Α	
	Pulse (Note 1)	I <sub>DP</sub>	64	Α	
Drain power dissipation	n (Tc = 25°C)	$P_{D}$	150	W	
Single-pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	979	mJ	
Avalanche current		I <sub>AR</sub>	16	Α	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	15	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature ra	ange	T <sub>stg</sub>	-55~150	°C	



Weight: 3.8 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

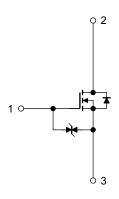
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	0.833	°C/W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	50	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 6.69 mH,  $R_{G}$  = 25  $\Omega$ ,  $I_{AR}$  = 16 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



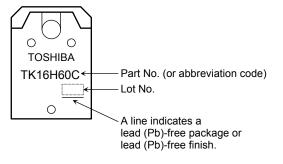
# **Electrical Characteristics (Ta = 25°C)**

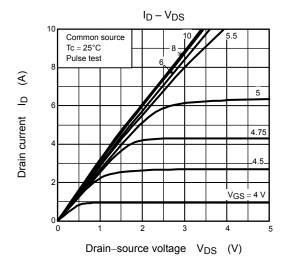
Chara	cteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	rrent	$I_{GSS}$	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V		_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cutoff curr	ent	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V <sub>(BR) DSS</sub>	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	600	_	_	V
Gate threshold v	oltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 8 A	_	0.32	0.4	Ω
Forward transfer	admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 8 A	3.0	11	_	S
Input capacitano	е	C <sub>iss</sub>		_	3100	_	
Reverse transfe	r capacitance	nce C <sub>rss</sub> V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1 MHz		_	20	_	pF
Output capacitance		Coss		_	270	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS}$ $\stackrel{10}{0}$ $V$ $\stackrel{I_{D}}{\longrightarrow}$ $R_{L} = 25 \Omega$ $V_{DD} \simeq 200 \ V$ Duty $\leq 1\%$ , $t_{w} = 10 \ \mu s$	_	60	_	
	Turn-on time	t <sub>on</sub>		_	110	_	20
	Fall time	t <sub>f</sub>			50		ns
	Turn-off time	t <sub>off</sub>		-	215	-	
Total gate charg plus gate-drain)		Qg		_	62	_	
Gate-source charge		$Q_{gs}$	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 16 \text{ A}$	_	40	_	nC
Gate-drain ("Miller") charge		$Q_{gd}$			22	_	

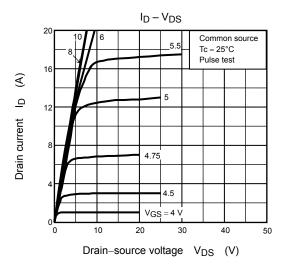
# Source-Drain Ratings and Characteristics (Ta = 25°C)

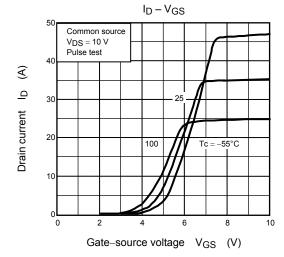
Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	16	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_		_	64	Α
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 16 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 16 A, V <sub>GS</sub> = 0 V		1050		ns
Reverse recovery charge	Q <sub>rr</sub>	dI <sub>DR</sub> / dt = 100 A / μs	1	15	_	μC

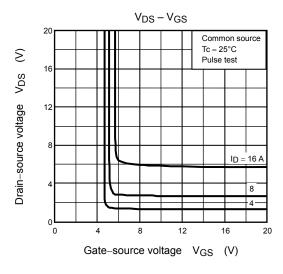
## Marking

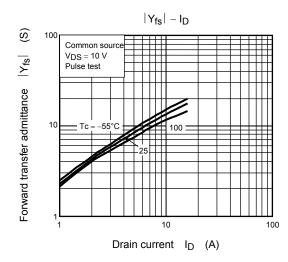


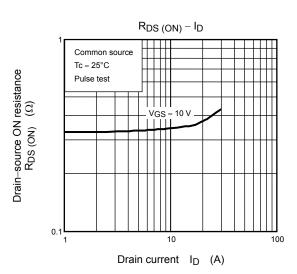




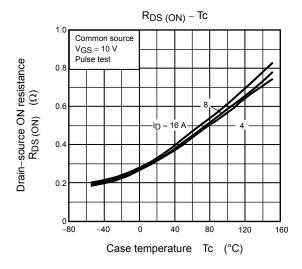


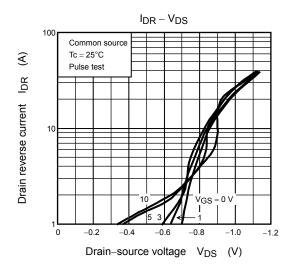


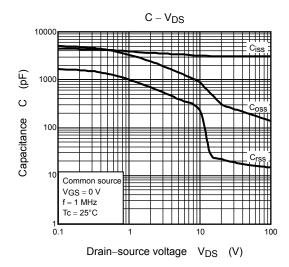


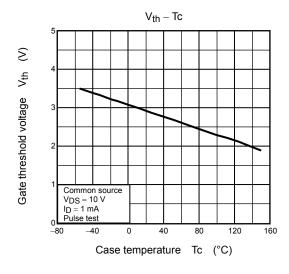


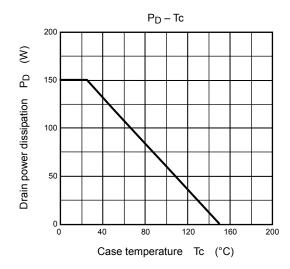
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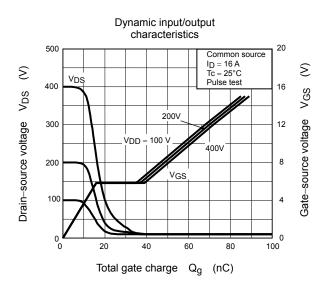


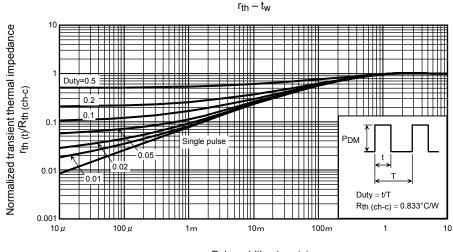


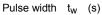


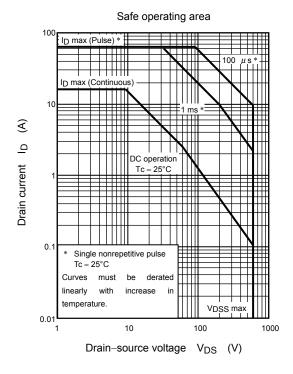


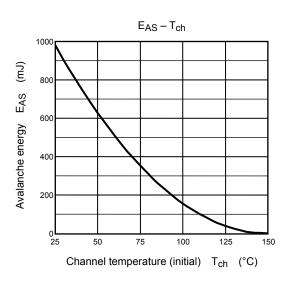


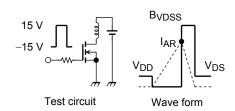












$$\begin{aligned} R_G &= 25~\Omega \\ V_{DD} &= 90~V,~L = 6.69~mH \end{aligned} \qquad EAS &= \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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